

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/532,962	LEIMU ET AL.	
Examiner	Art Unit	
Eric Hug	1731	

SEARCHED				
Class	Subclass	Date	Examiner	
162	363 364 367 370	5/16/2007	EH	
162	371 374			
277	303 412			
34	109 111			
34	116 117			
34	120			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST- USPAT, USOCR, PGPUB, JPO, EPO, Derwent	5/16/2007	EH	
Assignee and inventor search			
D21F 5/00 and subclasses			
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